MA4L728

Silicon epitaxial planar type

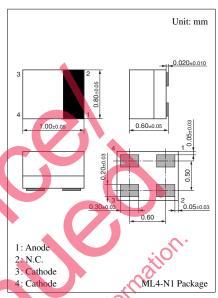
For high speed switching For wave detection

■ Features

- \bullet Low forward voltage V_F and good wave detection efficiency η
- Small reverse current I_R
- Small temperature coefficient of forward characteristic
- 1008-type mold leadless 4-pin package

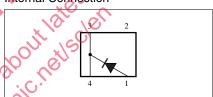
■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit
Reverse voltage (DC)	V_R	30	v
Peak reverse voltage	V_{RM}	30	V
Forward current (DC)	I_F	30	mA
Peak forward current	I_{FM}	150	mA
Junction temperature	T _j	125	°C
Storage temperature	T _{stg}	-55 to +125	°C



Marking Symbol: 2

Internal Connection



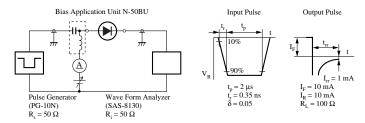
■ Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Reverse current (DC)	I_R	$V_R = 30 \text{ V}$			300	nA
Forward voltage (DC)	$V_{\rm FI}$	$I_F = 1 \text{ m}\lambda$			0.4	V
	V_{F2}	I _F =30 mA			1.0	
Terminal capacitance	C _t	$V_R = 1 V, f = 1 \text{ MHz}$		1.5		pF
Reverse recovery time *	t _{rr}	$I_F = I_R = 10 \text{ mA}$		1.0		ns
		$I_{rr} = 1 \text{ mA}, R_{L} = 100 \Omega$				
Detection efficiency	On	$V_{in} = 3 V_{(peak)}$, $f = 30 MHz$		65		%
	0/6	$R_L = 3.9 \Omega$, $C_L = 10 pF$				

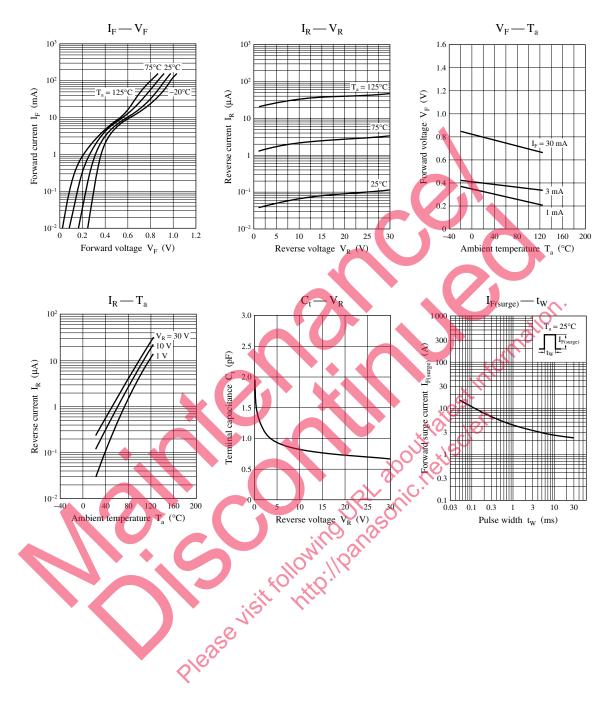
Note) 1. This product is sensitive to electric shock (static electricity, etc.).

Due attention must be paid on the charge of a human body and the leakage of current from the operating equipment.

2. Rated input/output frequency: 2 GHz 3. *: t_{rr} measuring instrument



Panasonic MA4L728



0.1 0.3

Pulse width tw (ms)

2 SKH00100AED

 10^{-2}

80 120

Ambient temperature T_a (°C)

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